



## Absolute Maximum Ratings $(T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	N Channel	P Channel	Unit
$V_{DSS}$	Drain-Source Voltage	30	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	
$I_D^*$	Continuous Drain Current	$V_{GS}=10\text{V (N)}$	-6	A
$I_{DM}^*$	Pulsed Drain Current	$V_{GS}=-10\text{V (P)}$	-20	
$I_S^*$	Diode Continuous Forward Current	1.2	-1	A
$T_J$	Maximum Junction Temperature	150		$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to 150		
$P_D^*$	Power Dissipation	$T_A=25^\circ\text{C}$	2	W
		$T_A=100^\circ\text{C}$	0.8	
$R_{\theta JA}^*$	Thermal Resistance-Junction to Ambient	62.5		$^\circ\text{C/W}$

Note:

\*Surface Mounted on  $1\text{in}^2$  pad area,  $t \leq 10\text{sec}$ .

## Electrical Characteristics $(T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	APM4548K			Unit	
			Min.	Typ.	Max.		
<b>Static Characteristics</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	N-Ch	30		V	
		$V_{GS}=0\text{V}, I_{DS}=-250\mu\text{A}$	P-Ch	-30			
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$	N-Ch		1	$\mu\text{A}$	
					30		
		$V_{DS}=-24\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$	P-Ch		-1		
					-30		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	N-Ch	1	1.5	2	V
		$V_{DS}=V_{GS}, I_{DS}=-250\mu\text{A}$	P-Ch	-1	-1.5	-2	
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	N-Ch			$\pm 100$	nA
			P-Ch			$\pm 100$	
$R_{DS(ON)}^a$	Drain-Source On-State Resistance	$V_{GS}=10\text{V}, I_{DS}=7\text{A}$	N-Ch		18	24	$\text{m}\Omega$
		$V_{GS}=-10\text{V}, I_{DS}=-6\text{A}$	P-Ch		32	42	
		$V_{GS}=4.5\text{V}, I_{DS}=5\text{A}$	N-Ch		23	30	
		$V_{GS}=-4.5\text{V}, I_{DS}=-5\text{A}$	P-Ch		42	55	

## Electrical Characteristics (Cont.) (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	APM4548K			Unit	
			Min.	Typ.	Max.		
<b>Diode Characteristics</b>							
V <sub>SD</sub> <sup>a</sup>	Diode Forward Voltage	I <sub>SD</sub> =2A, V <sub>GS</sub> =0V	N-Ch		0.8	1.3	V
		I <sub>SD</sub> =-2.3A, V <sub>GS</sub> =0V	P-Ch		-0.8	-1.3	
<b>Dynamic Characteristics<sup>b</sup></b>							
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	N-Ch		2.5		Ω
			P-Ch		11		
C <sub>iss</sub>	Input Capacitance	N-Channel V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, Frequency=1.0MHz	N-Ch		960		pF
C <sub>oss</sub>	Output Capacitance		P-Ch		980		
		N-Ch		180			
P-Ch		155					
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, Frequency=1.0MHz	N-Ch		100		
			P-Ch		120		
t <sub>d(ON)</sub>	Turn-on Delay Time	N-Channel V <sub>DD</sub> =15V, R <sub>L</sub> =15Ω, I <sub>DS</sub> =1A, V <sub>GEN</sub> =10V, R <sub>G</sub> =6Ω	N-Ch		7	14	ns
			P-Ch		7	14	
T <sub>r</sub>	Turn-on Rise Time		N-Ch		9	17	
			P-Ch		10	20	
t <sub>d(OFF)</sub>	Turn-off Delay Time	P-Channel V <sub>DD</sub> =-15V, R <sub>L</sub> =15Ω, I <sub>DS</sub> =-1A, V <sub>GEN</sub> =-10V, R <sub>G</sub> =6Ω	N-Ch		34	62	
			P-Ch		38	70	
T <sub>f</sub>	Turn-off Fall Time		N-Ch		12	23	
			P-Ch		14	26	
Q <sub>rr</sub>	Reverse Recovery Charge	N-Channel I <sub>SD</sub> =7A, dI <sub>SD</sub> /dt =100A/μs P-Channel I <sub>SD</sub> =-6A, dI <sub>SD</sub> /dt =100A/μs	N-Ch		5		nC
			P-Ch		3		
<b>Gate Charge Characteristics<sup>b</sup></b>							
Q <sub>g</sub>	Total Gate Charge	N-Channel V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>DS</sub> =7A	N-Ch		19	25	nC
			P-Ch		24	30	
Q <sub>gs</sub>	Gate-Source Charge		N-Ch		2		
			P-Ch		2		
Q <sub>gd</sub>	Gate-Drain Charge	P-Channel V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V, I <sub>DS</sub> =-6A	N-Ch		3.6		
			P-Ch		3.7		

**Notes:**

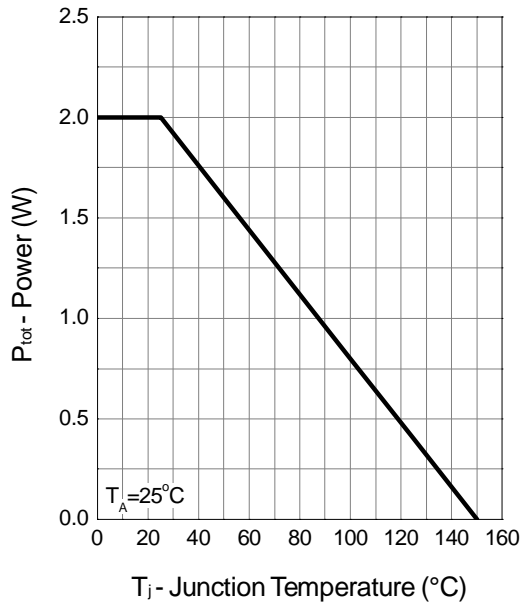
a : Pulse test ; pulse width ≤ 300μs, duty cycle ≤ 2%.

b : Guaranteed by design, not subject to production testing.

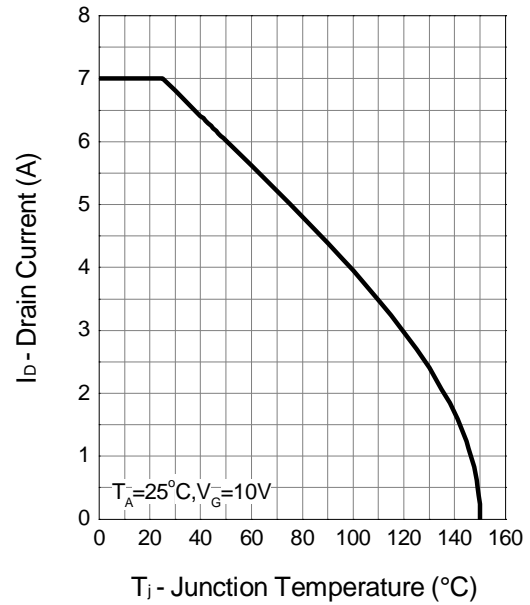
# Typical Characteristics

## N-Channel

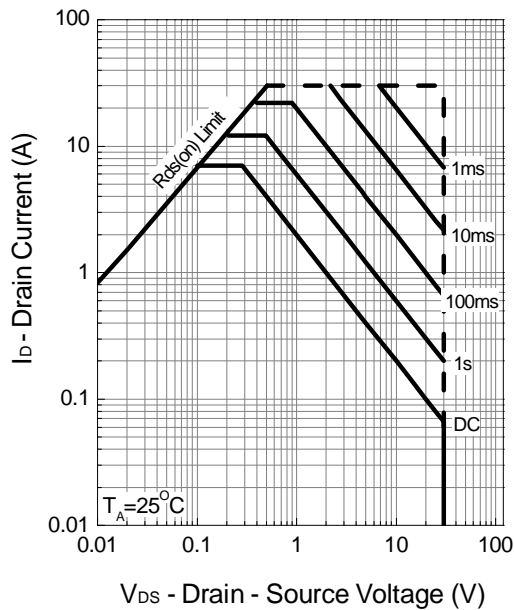
Power Dissipation



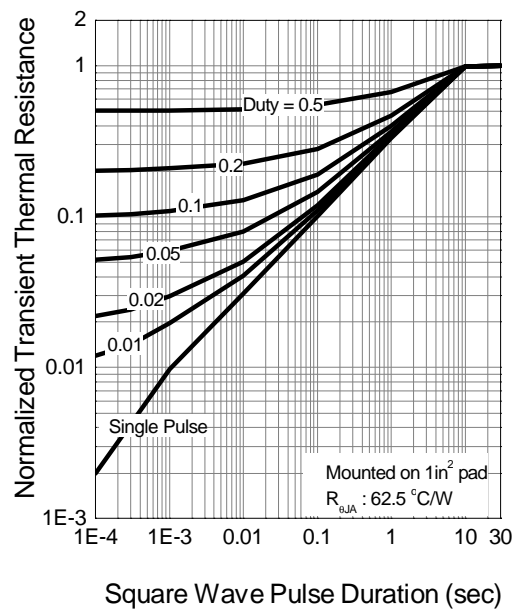
Drain Current



Safe Operation Area



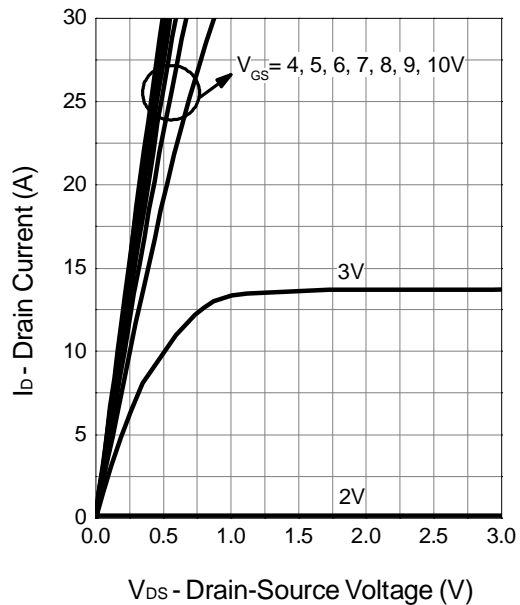
Thermal Transient Impedance



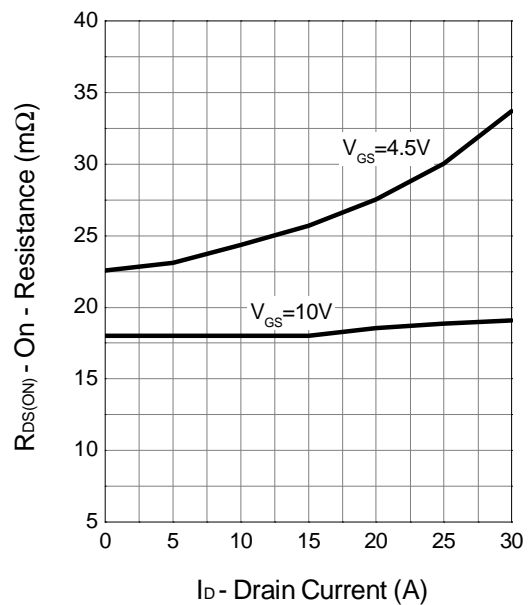
## Typical Characteristics (Cont.)

### N-Channel

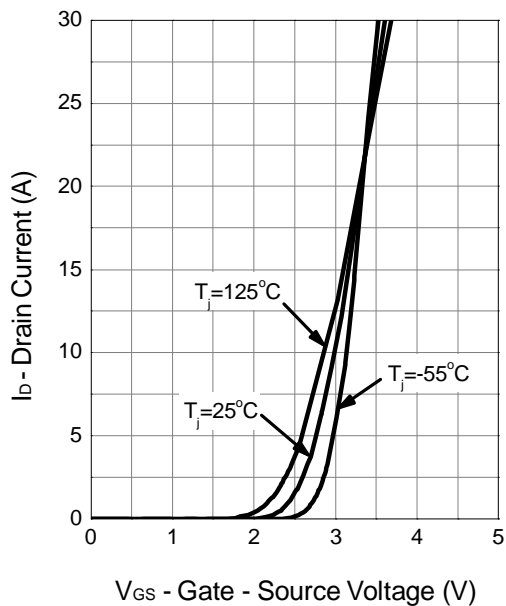
Output Characteristics



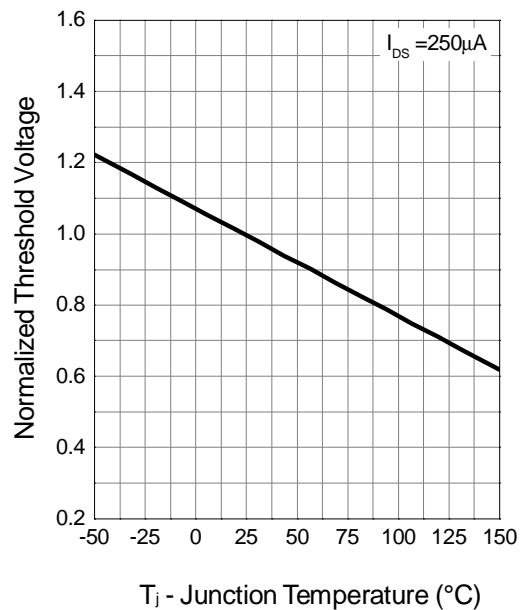
Drain-Source On Resistance



Transfer Characteristics



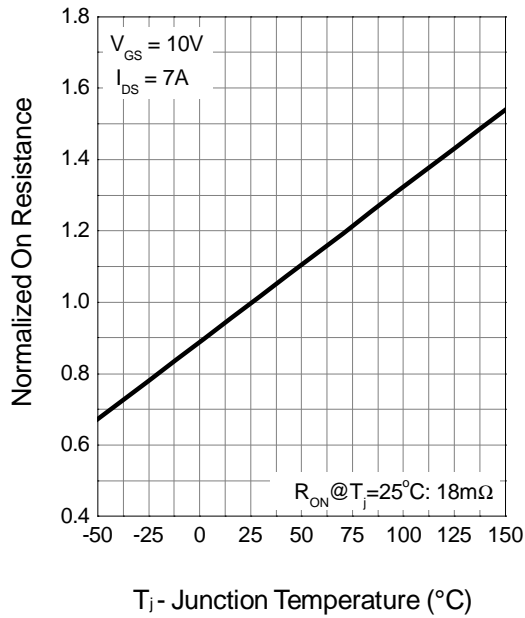
Gate Threshold Voltage



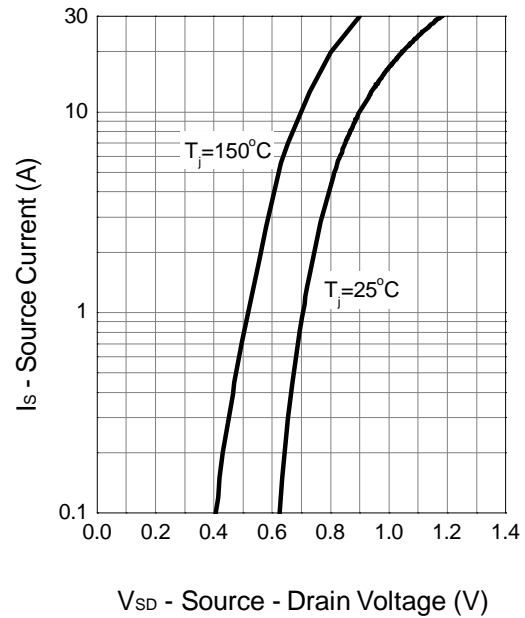
## Typical Characteristics (Cont.)

### N-Channel

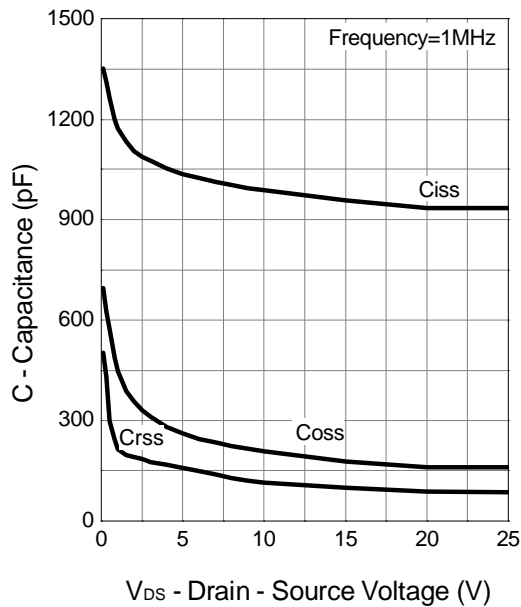
**Drain-Source On Resistance**



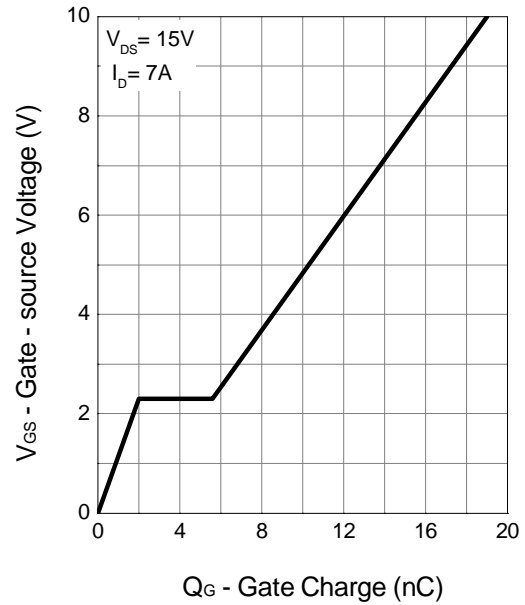
**Source-Drain Diode Forward**



**Capacitance**



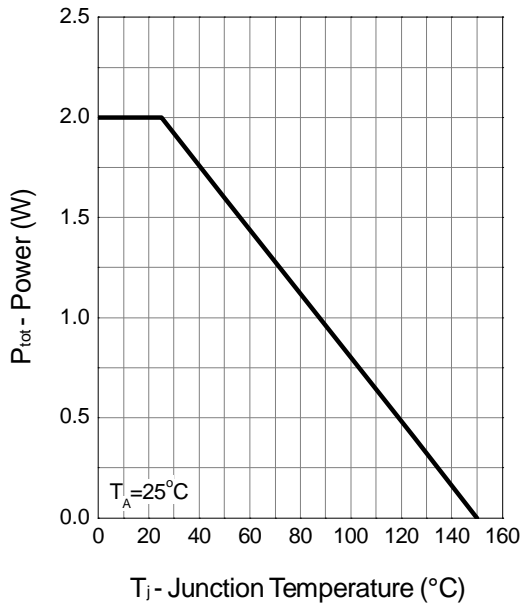
**Gate Charge**



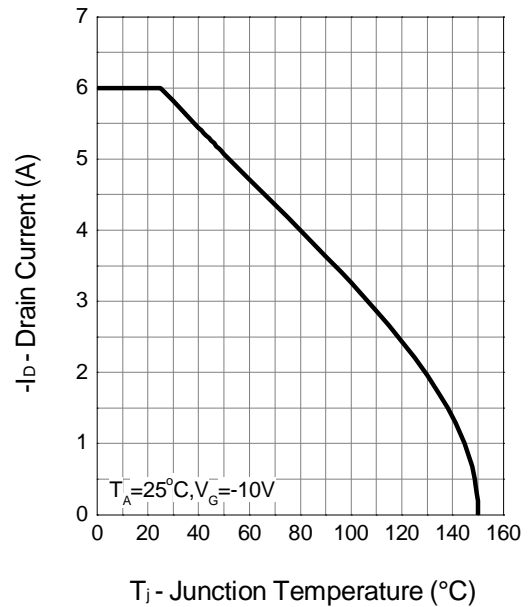
## Typical Characteristics (Cont.)

### P-Channel

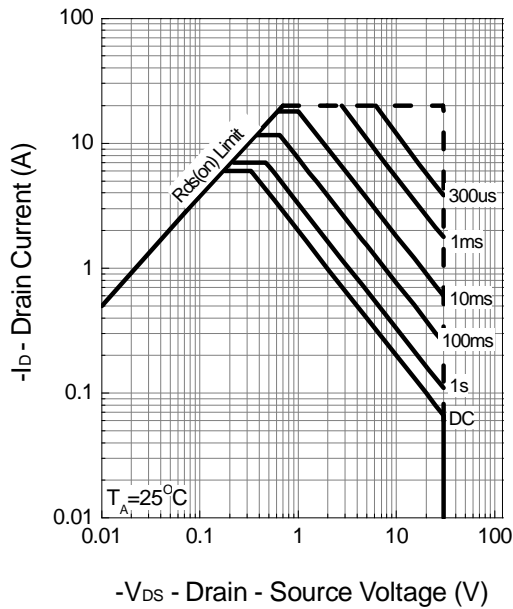
Power Dissipation



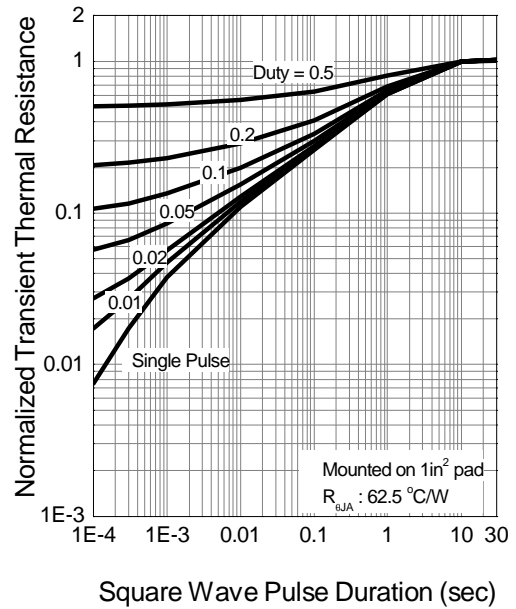
Drain Current



Safe Operation Area



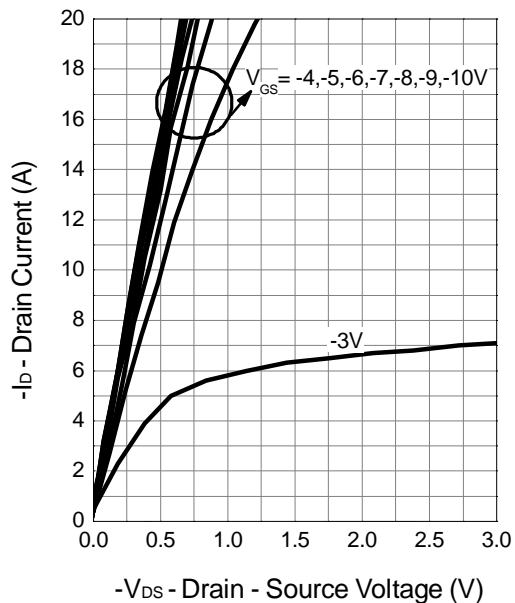
Thermal Transient Impedance



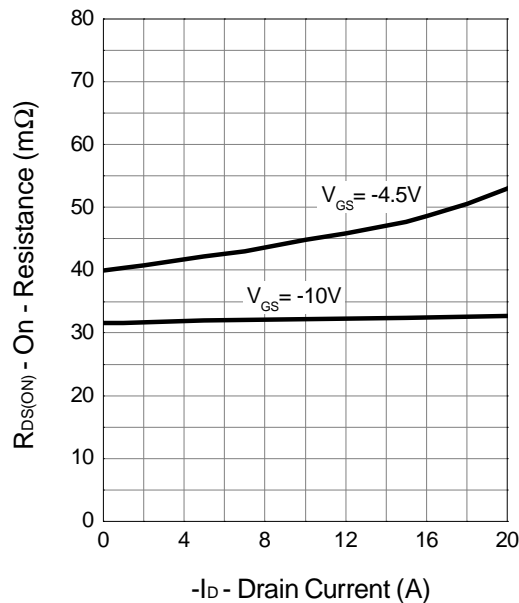
## Typical Characteristics (Cont.)

### P-Channel

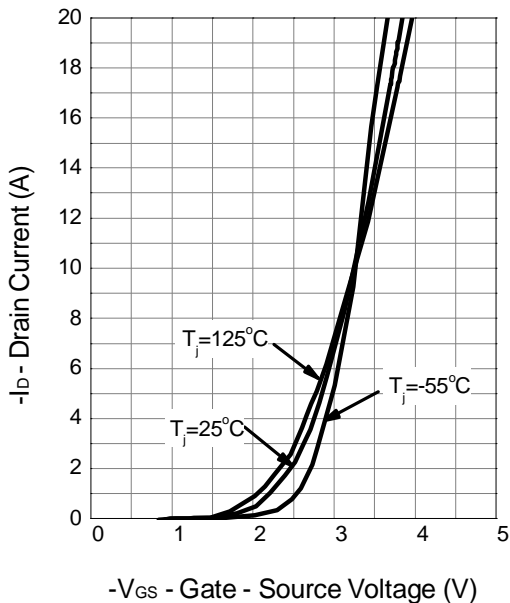
Output Characteristics



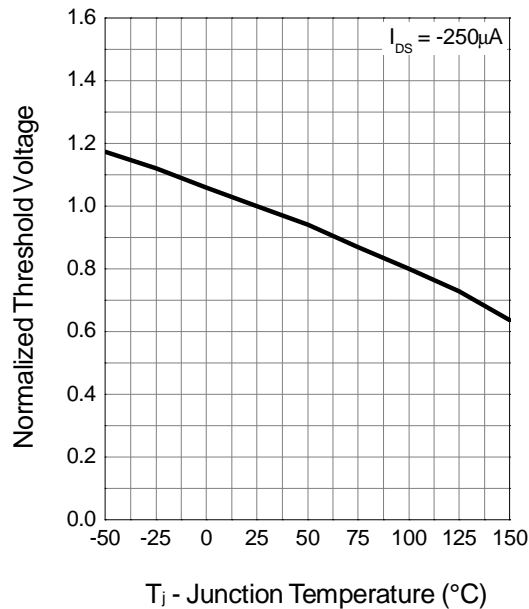
Drain-Source On Resistance



Transfer Characteristics



Gate Threshold Voltage

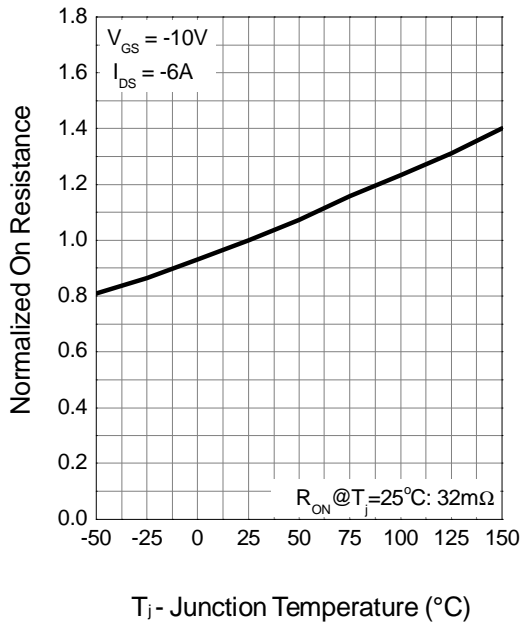




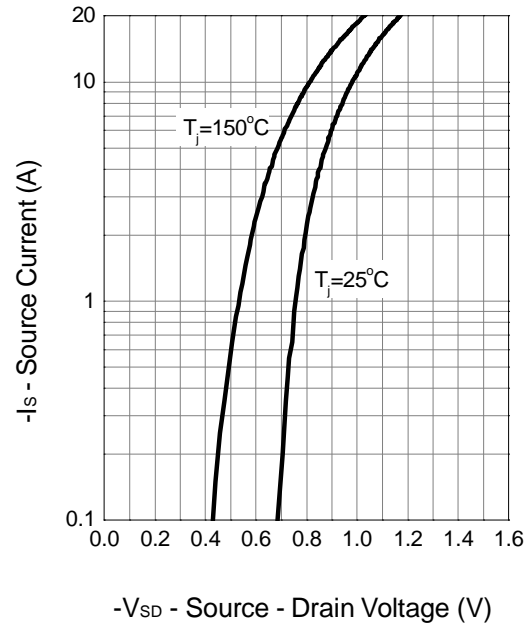
## Typical Characteristics (Cont.)

### P-Channel

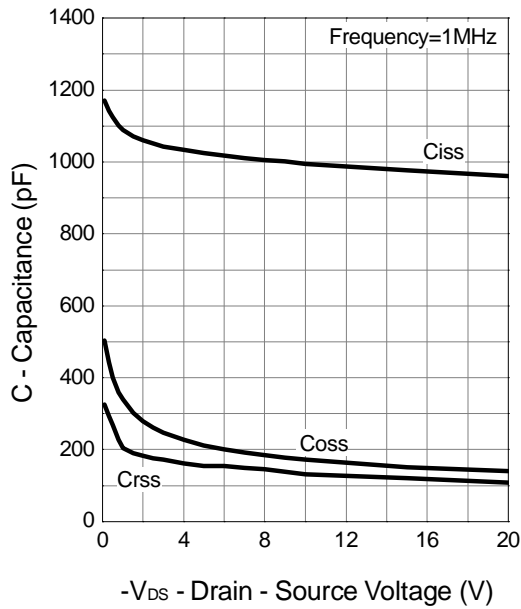
Drain-Source On Resistance



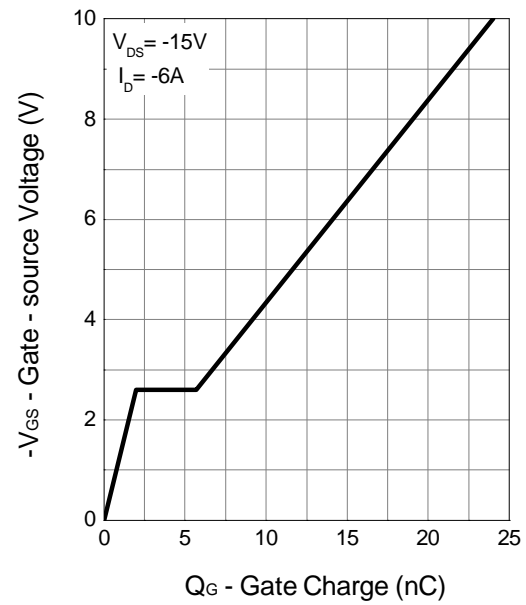
Source-Drain Diode Forward



Capacitance

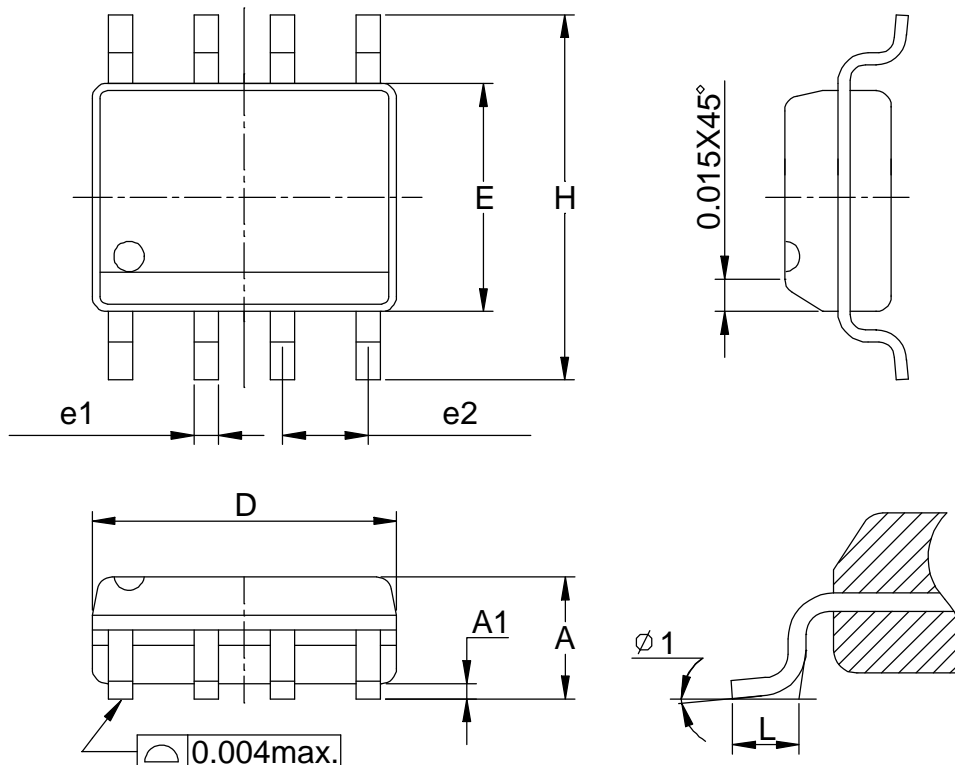


Gate Charge



## Packaging Information

SOP-8 pin ( Reference JEDEC Registration MS-012)

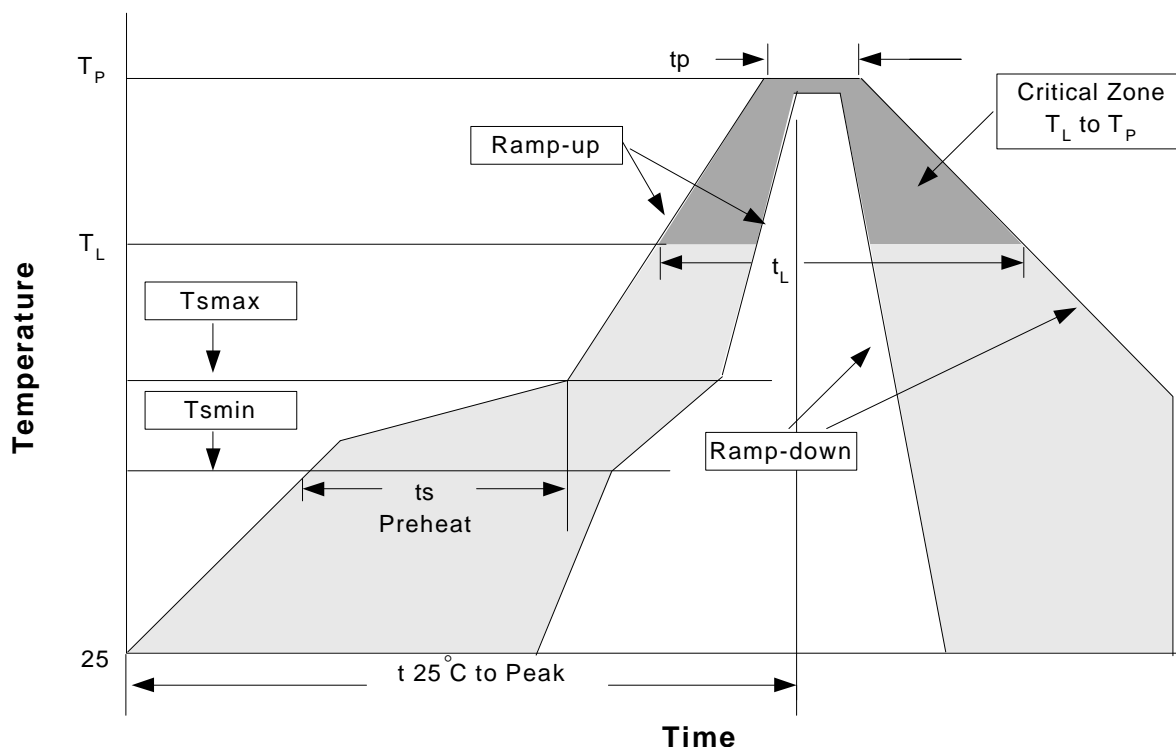


Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
D	4.80	5.00	0.189	0.197
E	3.80	4.00	0.150	0.157
H	5.80	6.20	0.228	0.244
L	0.40	1.27	0.016	0.050
e1	0.33	0.51	0.013	0.020
e2	1.27BSC		0.50BSC	
φ 1	8°		8°	

## Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb), 100%Sn
Lead Solderability	Meets EIA Specification RSI86-91, ANSI/J-STD-002 Category 3.

### Reflow Condition (IR/Convection or VPR Reflow)



### Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second max.	3°C/second max.
Preheat		
- Temperature Min (T <sub>smin</sub> )	100°C	150°C
- Temperature Max (T <sub>smax</sub> )	150°C	200°C
- Time (min to max) (t <sub>s</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
- Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak/Classification Temperature (T <sub>p</sub> )	See table 1	See table 2
Time within 5°C of actual Peak Temperature (t <sub>p</sub> )	10-30 seconds	20-40 seconds
Ramp-down Rate	6°C/second max.	6°C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Notes: All temperatures refer to topside of the package .Measured on the body surface.

## Classification Reflow Profiles(Cont.)

Table 1. SnPb Eutectic Process – Package Peak Reflow Temperatures

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> ≥350
<2.5 mm	240 +0/-5°C	225 +0/-5°C
≥2.5 mm	225 +0/-5°C	225 +0/-5°C

Table 2. Pb-free Process – Package Classification Reflow Temperatures

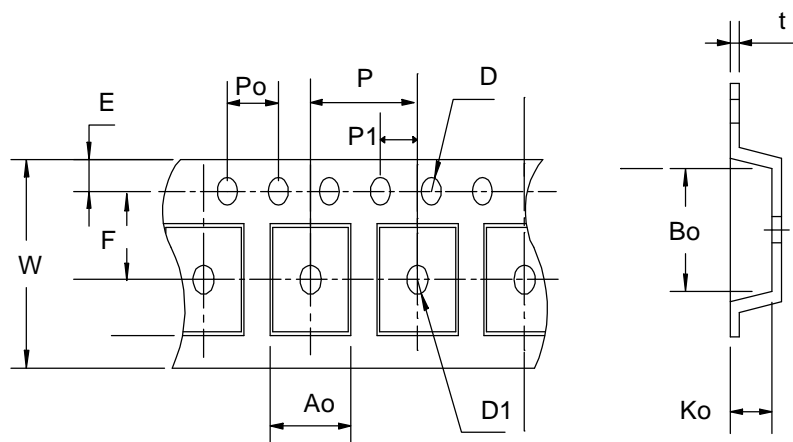
Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> 350-2000	Volume mm <sup>3</sup> >2000
<1.6 mm	260 +0°C*	260 +0°C*	260 +0°C*
1.6 mm – 2.5 mm	260 +0°C*	250 +0°C*	245 +0°C*
≥2.5 mm	250 +0°C*	245 +0°C*	245 +0°C*

\*Tolerance: The device manufacturer/supplier **shall** assure process compatibility up to and including the stated classification temperature (this means Peak reflow temperature +0°C. For example 260°C+0°C) at the rated MSL level.

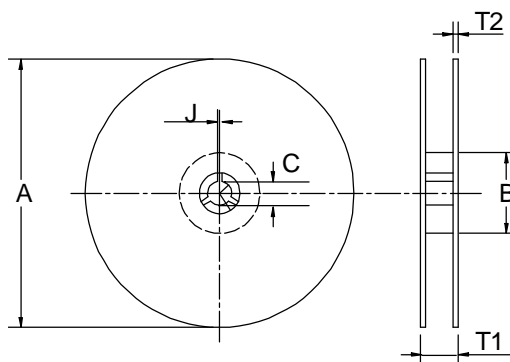
## Reliability Test Program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @ 125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

## Carrier Tape & Reel Dimensions



Carrier Tape & Reel Dimensions(Cont.)



Application	A	B	C	J	T1	T2	W	P	E
SOP-8	330±1	62 ± 1.5	12.75 + 0.15	2 + 0.5	12.4 +0.2	2± 0.2	12 + 0.3 - 0.1	8± 0.1	1.75± 0.1
	F	D	D1	Po	P1	Ao	Bo	Ko	t
	5.5 ± 0.1	1.55±0.1	1.55+ 0.25	4.0 ± 0.1	2.0 ± 0.1	6.4 ± 0.1	5.2± 0.1	2.1± 0.1	0.3±0.013

(mm)

Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
SOP- 8	12	9.3	2500

Customer Service

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